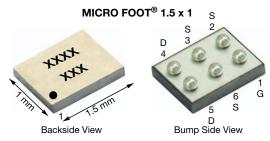


Vishay Siliconix

# P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)		
	0.053 at V <sub>GS</sub> = -4.5 V	-13			
-30	0.071 at V <sub>GS</sub> = -2.5 V	-11	16.3 nC		
	0.120 at V <sub>GS</sub> = -2 V	-5			



Marking Code: xxxx = 8497

xxx = Date / lot traceability code

#### **Ordering Information:**

Si8497DB-T2-E1 (Lead (Pb)-free and halogen-free)

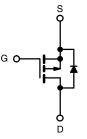
#### **FEATURES**

- TrenchFET® power MOSFET
- Ultra-small 1.5 mm x 1 mm maximum outline
- Ultra-thin 0.59 mm maximum height
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912



#### **APPLICATIONS**

- Low on-resistance load switch, charger switch, OVP switch and battery switch for portable devices
  - Low power consumption
  - Increased battery life
  - Space savings on PCB



P-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	-30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 12	
	T <sub>C</sub> = 25 °C		-13	
Continuous Dunin Comment /T. 150 °C)	T <sub>C</sub> = 70 °C		-10	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-5.9 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		-4.7 <sup>a, b</sup>	А
Pulsed Drain Current (t = 300 μs)	I <sub>DM</sub>	-20		
Ossilia as a Ossava Buria Biada Ossaval	T <sub>C</sub> = 25 °C		-11	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub> —	-2.3 <sup>a, b</sup>	
	T <sub>C</sub> = 25 °C		13	
Maximum Bayyar Dissination	T <sub>C</sub> = 70 °C		8.4	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.77 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C		1.77 <sup>a, b</sup>	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	
Package Reflow Conditions c	IR/Convection		260	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a, e	R <sub>thJA</sub>	37	45	°C/W			
Maximum Junction-to-Case (Drain) f	Steady State	R <sub>thJC</sub>	7	9.5	- C/VV		

## Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Based on  $T_C = 25$  °C.
- e. Maximum under steady state conditions is 85 °C/W.
- f. Case is defined as top surface of the package.



# Vishay Siliconix

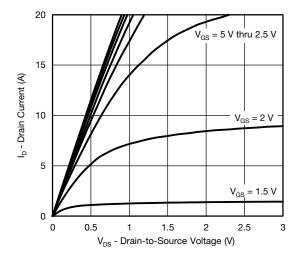
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				•		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0, I_D = -250 \mu\text{A}$		-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-29	-	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	3.1	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.5	-	-1.1	٧
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 100	nA
Zana Oata Maltana Duain Oriumant		V <sub>DS</sub> = -30 V, V <sub>GS</sub> = 0 V	-	-	-1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	-10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-5	-	-	Α
		$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$	-	0.043	0.053	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -2.5 \text{ V}, I_D = -1 \text{ A}$	-	0.058	0.071	
	, ,	$V_{GS} = -2 \text{ V}, I_D = -0.5 \text{ A}$	-	0.075	0.120	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -1.5 A	-	10	-	S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>		-	1320	-	pF
Output Capacitance	Coss	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	121	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	102	-	
Total Gate Charge	Qg	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -1.5 \text{ A}$	-	32.6	49	nC
Total Gate Charge			-	16.3	25	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.5 \text{ A}$	-	2.5	-	
Gate-Drain Charge	$Q_{gd}$		-	4.9	-	
Gate Resistance	$R_g$	$V_{GS} = -0.1 \text{ V, f} = 1 \text{ MHz}$	-	8	-	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	17	35	
Rise Time	t <sub>r</sub>	$V_{DD}$ = -15 V, $R_L$ = 10 $\Omega$	-	15	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	60	120	
Fall Time	t <sub>f</sub>		-	25	50	
Turn-On Delay Time	t <sub>d(on)</sub>		-	50	100	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = -15 V, $R_L$ = 10 $\Omega$	-	10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	75	150	
Fall Time	t <sub>f</sub>		-	22	45	
<b>Drain-Source Body Diode Characteris</b>	tics					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-15	Α
Pulse Diode Forward Current	I <sub>SM</sub>		-	-	-20	A
Body Diode Voltage	$V_{SD}$	$I_S = -1.5 \text{ A}, V_{GS} = 0$	-	-0.73	-1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	21	40	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	I <sub>F</sub> = -1.5 A, dl/dt = 100 A/μs, T <sub>.I</sub> = 25 °C	-	7	15	nC
Reverse Recovery Fall Time	ta	$_{1F} = -1.5 \text{ A}$ , $_{100}$ $_{100}$ $_{100}$ $_{100}$ $_{100}$ $_{100}$ $_{100}$ $_{100}$	-	8	-	ns
Reverse Recovery Rise Time	t <sub>b</sub>		_	13	=	

## Notes

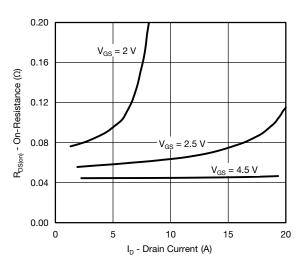
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

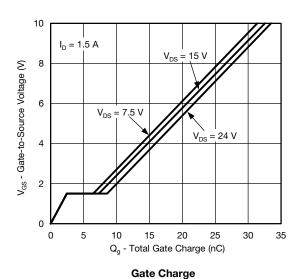




## **Output Characteristics**



On-Resistance vs. Drain Current and Gate Voltage



10

8

T<sub>C</sub> = 25 °C

T<sub>C</sub> = -55 °C

0

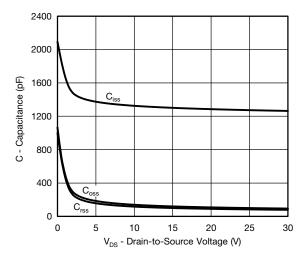
0

0.5

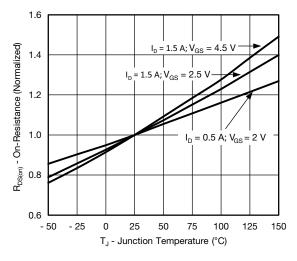
1.5

V<sub>GS</sub> - Gate-to-Source Voltage (V)

**Transfer Characteristics** 

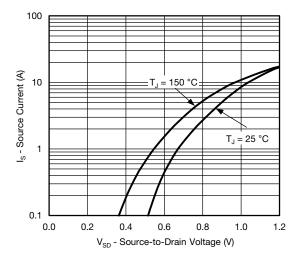


Capacitance

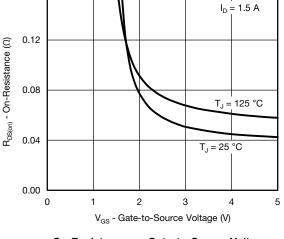


On-Resistance vs. Junction Temperature

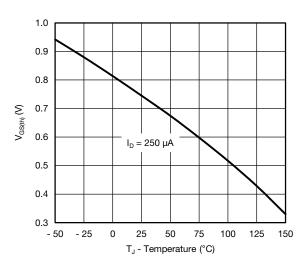




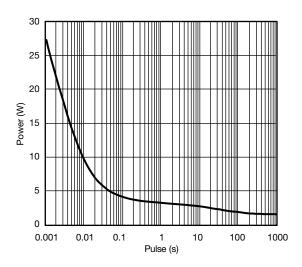
#### Source-Drain Diode Forward Voltage



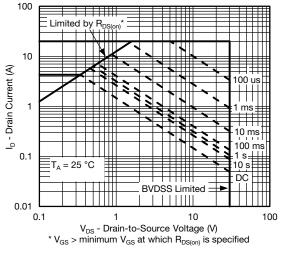
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

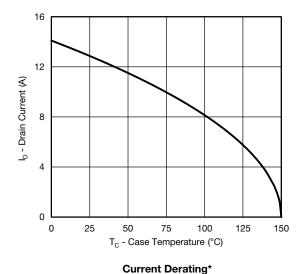


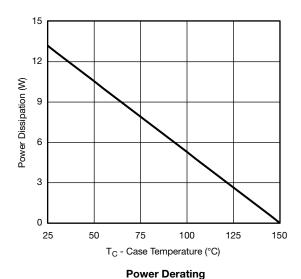
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

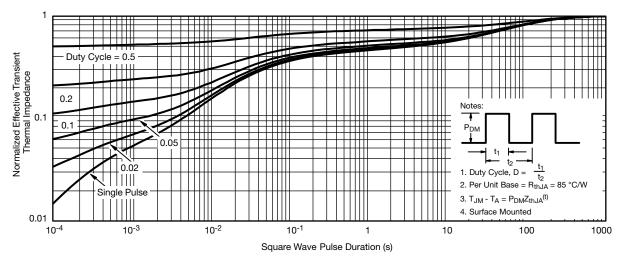




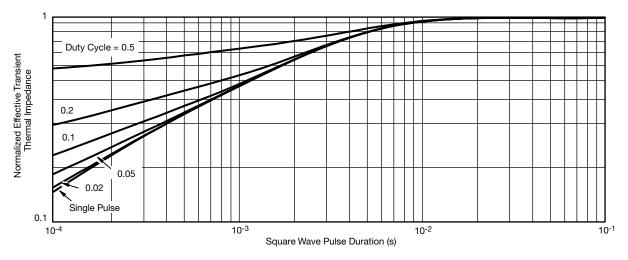


 $^*$  The power dissipation P<sub>D</sub> is based on T<sub>J (max.)</sub> = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

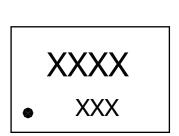


Normalized Thermal Transient Impedance, Junction-to-Case

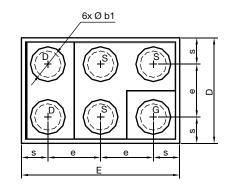
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg263355">www.vishay.com/ppg263355</a>.

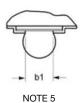


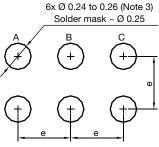
# MICRO FOOT®: 6-Bump (1.5 mm x 1 mm, 0.5 mm Pitch, 0.250 mm Bump Height)



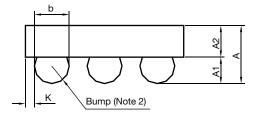
Mark on Backside of Die







Recommended Land Pattern



#### Notes

(unless otherwise specified)

- 1. Six (6) solder bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser marks on the silicon die back.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES				
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
А	0.510	0.575	0.590	0.0201	0.0226	0.0232		
A <sub>1</sub>	0.220	0.250	0.280	0.0087	0.0098	0.0110		
A <sub>2</sub>	0.290	0.300	0.310	0.0114	0.0118	0.0122		
b	0.297	0.330	0.363	0.0116	0.0129	0.0143		
b1		0.250			0.0098			
е	0.500			0.0197				
s	0.210	0.230	0.250	0.0082	0.0090	0.0098		
D	0.920	0.960	1.000	0.0362	0.0378	0.0394		
E	1.420	1.460	1.500	0.0559	0.0575	0.0591		
K	0.028	0.065	0.102	0.0011	0.0025	0.0040		

#### Note

Use millimeters as the primary measurement.

ECN: T15-0140-Rev. A, 20-Apr-15

DWG: 6035

Revison: 20-Apr-15 1 Document Number: 69426



# **Legal Disclaimer Notice**

Vishay

# **Disclaimer**

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Hyperlinks included in this datasheet may direct users to third-party websites. These links are provided as a convenience and for informational purposes only. Inclusion of these hyperlinks does not constitute an endorsement or an approval by Vishay of any of the products, services or opinions of the corporation, organization or individual associated with the third-party website. Vishay disclaims any and all liability and bears no responsibility for the accuracy, legality or content of the third-party website or for that of subsequent links.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.